

**Search Notes**

Application/Control No.

10/725,133

Examiner

W. Patty Chen

Applicant(s)/Patent under  
Reexamination

LEE ET AL.

Art Unit

2871

**SEARCHED**

Class	Subclass	Date	Examiner
349	145,146	10/17/2006	WPC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Citations search of relevant references	10/17/2006	WPC
349/141, 145-146 combined with key words search of all databases in EAST	10/17/2006	WPC